

**Search Notes**

Application/Control No.

10/790,871

Examiner

James D. Stein

Applicant(s)/Patent under  
Reexamination

TATEIWA, AKIHIKO

Art Unit

2874

**SEARCHED**

Class	Subclass	Date	Examiner
385	27,31,39, 42	10/13/2005	JDS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
385	27,31,39	10/13/2005	JDS
385	42	10/13/2005	JDS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	10/13/2005	JDS
IEEE, INSPEC: collimator, GRIN fiber, graded index fiber, mirror	10/13/2005	JDS
USPGPUB interference search	10/13/2005	JDS
classification search: 385/15-52 -- keywords only.	10/13/2005	JDS